

PRODUCT SUMMARY

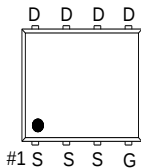
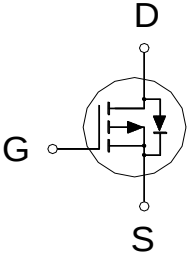
$V_{(BR)DSS}$	$R_{DS(ON)}$	I_D
-40V	14mΩ	-40A

Features

- Pb-Free, Halogen Free and RoHS compliant.
- Low $R_{DS(on)}$ to Minimize Conduction Losses.
- Ohmic Region Good $R_{DS(on)}$ Ratio.
- Optimized Gate Charge to Minimize Switching Losses.

Applications

- Protection Circuits Applications.
- Logic/Load Switch Circuits Applications.



G. GATE
D. DRAIN
S. SOURCE

100% UIS Tested
100% Rg Tested

ABSOLUTE MAXIMUM RATINGS (T_A = 25 °C Unless Otherwise Noted)

PARAMETERS/TEST CONDITIONS		SYMBOL	LIMITS	UNITS
Drain-Source Voltage		V_{DS}	-40	V
Gate-Source Voltage		V_{GS}	±25	V
Continuous Drain Current	$T_C = 25\text{ °C}$	I_D	-40	A
	$T_C = 100\text{ °C}$		-25	
	$T_A = 25\text{ °C}$		-11	
	$T_A = 70\text{ °C}$		-8.7	
Pulsed Drain Current ¹		I_{DM}	-114	
Avalanche Current		I_{AS}	-41	
Avalanche Energy	$L = 0.1\text{mH}$	E_{AS}	84	mJ
Power Dissipation ³	$T_C = 25\text{ °C}$	P_D	42	W
	$T_C = 100\text{ °C}$		17	
	$T_A = 25\text{ °C}$		3.2	
	$T_A = 70\text{ °C}$		2.1	
Junction & Storage Temperature Range		T_j, T_{stg}	-55 to 150	°C

THERMAL RESISTANCE RATINGS

THERMAL RESISTANCE		SYMBOL	TYPICAL	MAXIMUM	UNITS
Junction-to-Ambient ²	$t \leq 10s$	$R_{\theta JA}$		40	°C / W
Junction-to-Ambient ²	Steady-State	$R_{\theta JA}$		62	
Junction-to-Case	Steady-State	$R_{\theta JC}$		3	

¹Pulse width limited by maximum junction temperature.

²The value of $R_{\theta JA}$ is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with $T_A = 25^\circ\text{C}$.

³The Power dissipation is based on $R_{\theta JA}$ $t \leq 10s$ value.

ELECTRICAL CHARACTERISTICS ($T_J = 25^\circ\text{C}$, Unless Otherwise Noted)

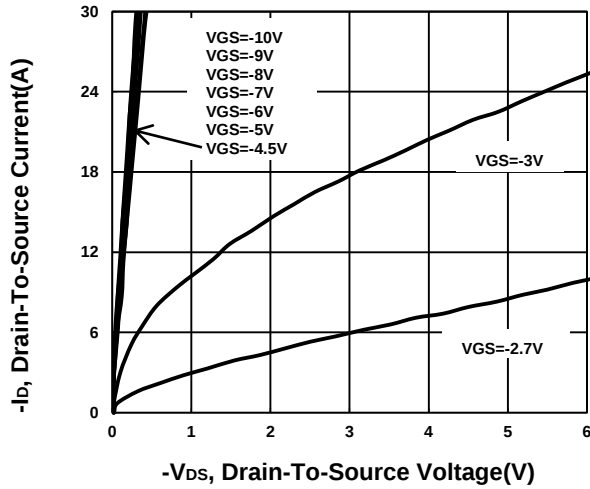
PARAMETER	SYMBOL	TEST CONDITIONS	LIMITS			UNIT
			MIN	TYP	MAX	
STATIC						
Drain-Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS} = 0V, I_D = -250\mu A$	-40			V
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = -250\mu A$	-1	-1.8	-3	
Gate-Body Leakage	I_{GSS}	$V_{DS} = 0V, V_{GS} = \pm 25V$			± 100	nA
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = -40V, V_{GS} = 0V$			-1	μA
		$V_{DS} = -40V, V_{GS} = 0V, T_J = 55\text{ }^{\circ}C$			-10	
Drain-Source On-State Resistance ¹	$R_{DS(ON)}$	$V_{GS} = -10V, I_D = -11A$		10	14	mΩ
		$V_{GS} = -4.5V, I_D = -11A$		14	20	
Forward Transconductance ¹	g_{fs}	$V_{DS} = -5V, I_D = -11A$		55		S
DYNAMIC						
Input Capacitance	C_{iss}	$V_{GS} = 0V, V_{DS} = -20V, f = 1MHz$		2504		pF
Output Capacitance	C_{oss}			317		
Reverse Transfer Capacitance	C_{rss}			246		
Gate Resistance	R_g	$V_{GS} = 0V, V_{DS} = 0V, f = 1MHz$		4.1		Ω
Total Gate Charge ²	$Q_{g(VGS=-10V)}$	$V_{DS} = -20V, I_D = -11A$		52		nC
	$Q_{g(VGS=-4.5V)}$			27		
Gate-Source Charge ²	Q_{gs}			6.4		
Gate-Drain Charge ²	Q_{gd}			12		

Turn-On Delay Time ²	t _{d(on)}	V _{DD} = -20V I _D ≅ -11A, V _{GS} = -10V, R _{GEN} = 6 Ω		13		nS
Rise Time ²	t _r			47		
Turn-Off Delay Time ²	t _{d(off)}			92		
Fall Time ²	t _f			89		
SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS (T _J = 25 °C)						
Continuous Current	I _S				-32	A
Forward Voltage ¹	V _{SD}	I _F = -11A, V _{GS} = 0V			-1.3	V
Reverse Recovery Time	t _{rr}	I _F = -11A, dI/dt = 100A/μs		16		nS
Reverse Recovery Charge	Q _{rr}			7.8		nC

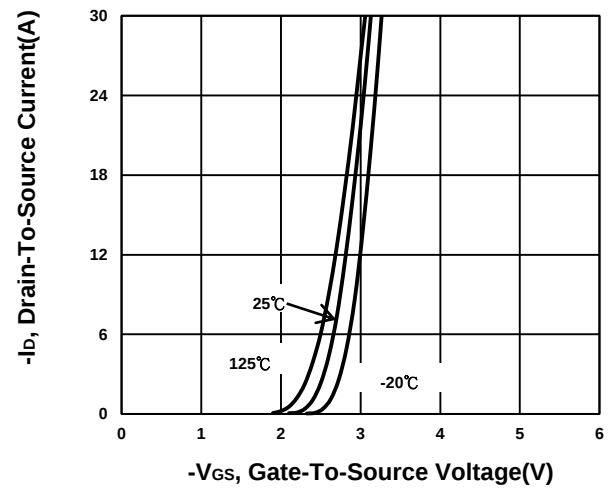
¹Pulse test : Pulse Width $\leq 300\text{ }\mu\text{sec}$, Duty Cycle $\leq 2\%$.

²Independent of operating temperature.

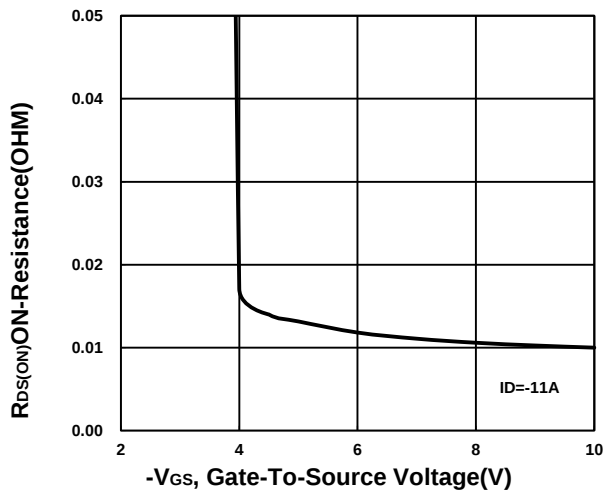
Output Characteristics



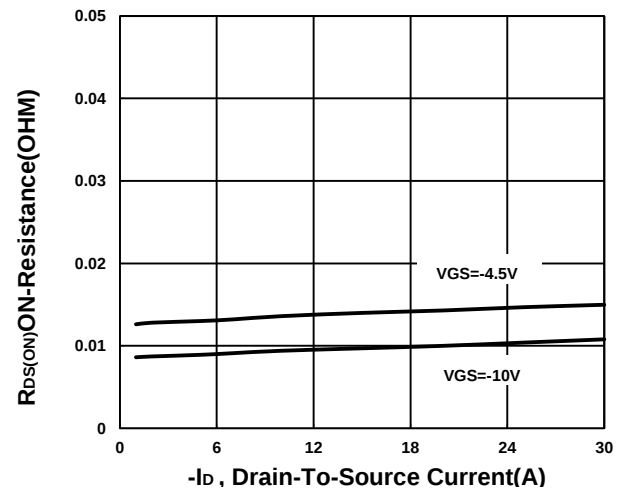
Transfer Characteristics



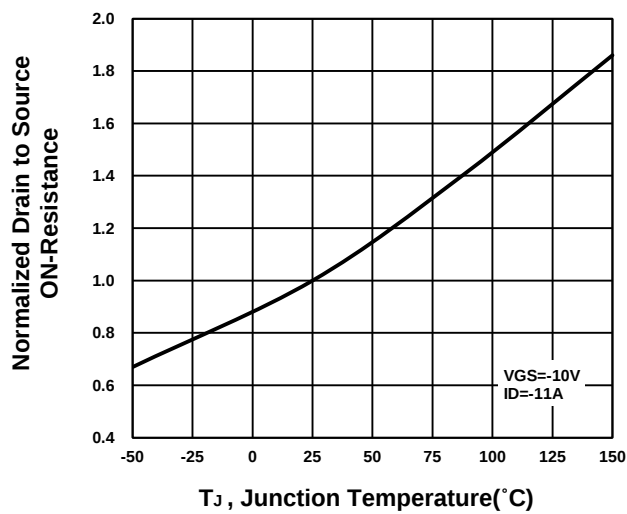
On-Resistance VS Gate-To-Source Voltage



On-Resistance VS Drain Current



On-Resistance VS Temperature



Capacitance Characteristic

